



SHEET 1 OF 1

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
60188-725SERIAL NO.
10/751,525APPLICANT
Mitsuyasu OHTA, et al.FILING DATE
January 06, 2004GROUP
2133

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Codez (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/CB/		US 5,258,985	11/02/1993	Spence et al.	
		US			
		US			
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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes - Number - Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
/CB/		EP 0472 818 A2	03/04/1992	INTERNATIONAL BUSINESS MACHINES CORPORATION		X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
/CB/		MO Chin Tsung., et al. " Self Diagnostic BIST Memory Design Scheme." IEEE, pp. 7-9, August 8, 1994
/CB/		WUNDERLICH et al. " Bit-Flipping BIST." IEEE, pp. 337-343, November 10, 1996

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